

# TLVx172 面向成本敏感型系统的 36V 单电源低功耗 运算放大器

## 1 特性

- 电源电压范围：4.5V 至 36V， $\pm 2.25V$  至  $\pm 18V$
- 低噪声： $9\text{ nV}/\sqrt{\text{Hz}}$
- 低偏移漂移： $\pm 1\mu\text{V}/^\circ\text{C}$ （典型值）
- 强化的电磁干扰 (EMI) 保护
- 输入范围包括负电源
- 轨到轨输出
- 增益带宽：10MHz
- 转换速率：10V/ $\mu\text{s}$
- 低静态电流：每个放大器 1.6mA
- 高共模抑制：116dB（典型值）
- 低输入偏压电流：10pA

## 2 应用

- 薄膜晶体管 (TFT) - 液晶显示屏 (LCD) 驱动电路
- 触摸屏显示屏
- 无线 LAN
- 便携式仪表
- 模数转换器 (ADC) 缓冲器
- 有源滤波器
- 线路驱动器或线路接收器
- 超声波
- 点钞机
- 变频器放大器

## 3 说明

TLVx172 系列强化电磁干扰 (EMI) 36V 单电源、低噪声运算放大器在频率为 1kHz 时具有 0.0002% 的总谐波失真 + 噪声 (THD+N)，电源电压范围为 4.5V ( $\pm 2.25V$ ) 至 36V ( $\pm 18V$ )。这些功能与低噪声和超高 PSRR 特性相结合，使得 TLVx172 成为放大毫伏级信号的理想选择。TLVx172 系列器件具有良好的偏移和漂移特性、10MHz 高带宽和 10V/ $\mu\text{s}$  转换率，在温度范围内的静态电流仅为 2.3mA（最大值）。

大多数运算放大器仅有一个指定的电源电压，TLVx172 系列运算放大器则有所不同，其可在 4.5V 至 36V 的电压范围内额定运行。超过电源轨的输入信号不会导致反相。TLVx172 系列在容性负载高达 300pF 时可保持稳定。输入可在负电源轨以下 100mV 以及正电源轨 2V 之内正常运行。请注意，这些器件可在正电源轨之上 100mV 的满轨到轨输入上运行，但是在正电源轨 2V 内运行时，性能会受到影响。

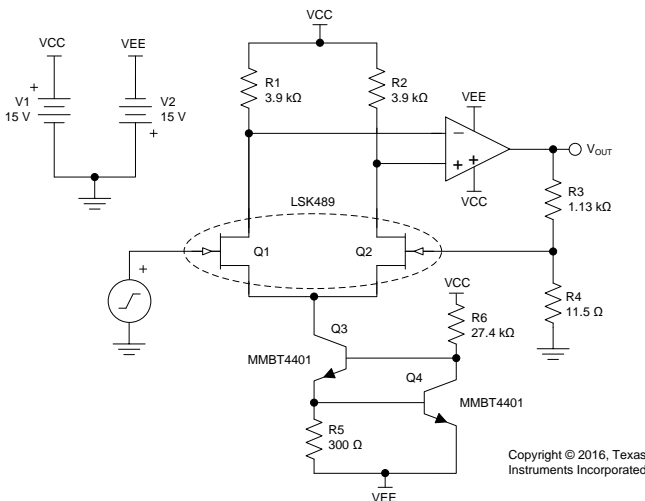
TLVx172 运算放大器的额定工作温度范围为  $-40^\circ\text{C}$  至  $+125^\circ\text{C}$ 。

### 器件信息<sup>(1)</sup>

器件型号	封装	封装尺寸 (标称值)
TLV172	SOIC (8)	4.90mm x 3.91mm
	SC70 (5)	2.00mm x 1.25mm
	SOT-23 (5)	2.90mm x 1.60mm
TLV2172	SOIC (8)	4.90mm x 3.91mm
	VSSOP (8)	3.00mm x 3.00mm
TLV4172	SOIC (14)	8.65mm x 3.91mm
	TSSOP (14)	5.00mm x 4.40mm

(1) 要了解所有可用封装，请见数据表末尾的可订购产品附录。

简化电路原理图



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## 4 修订历史记录

日期	修订版本	注释
2016 年 11 月	*	最初发布。

## 5 Device Comparison

**Device Comparison**

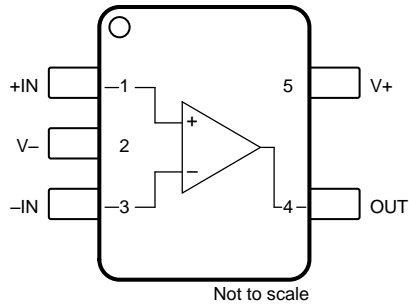
DEVICE	PACKAGE
TLV172 (single)	SC70-5, SOT-23-5, SOIC-8
TLV2172 (dual)	SOIC-8, VSSOP-8
TLV4172 (quad)	SOIC-14, TSSOP-14

**Device Family Comparison**

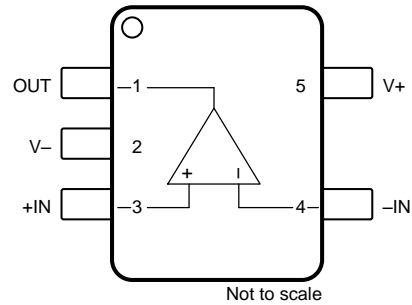
DEVICE	QUIESCENT CURRENT ( $I_Q$ )	GAIN BANDWIDTH PRODUCT (GBP)	VOLTAGE NOISE DENSITY ( $e_n$ )
<a href="#">TLVx172</a>	1600 $\mu$ A	10 MHz	9 nV/ $\sqrt{\text{Hz}}$
<a href="#">TLVx171</a>	525 $\mu$ A	3.0 MHz	16 nV/ $\sqrt{\text{Hz}}$
<a href="#">TLVx170</a>	125 $\mu$ A	1.2 MHz	22 nV/ $\sqrt{\text{Hz}}$

## 6 Pin Configuration and Functions

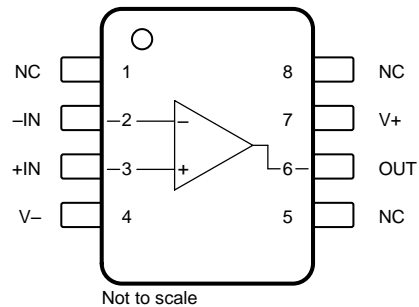
**TLV172: DCK Package  
5-Pin SC70  
Top View**



**TLV172: DBV Package  
5-Pin SOT-23  
Top View**



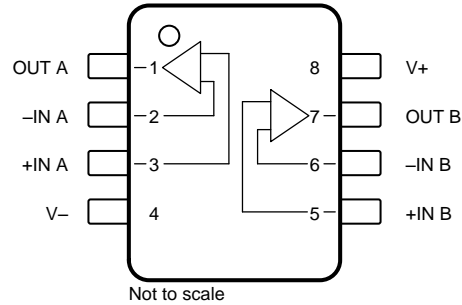
**TLV172: D Package  
8-Pin SOIC  
Top View**



### Pin Functions: TLV172

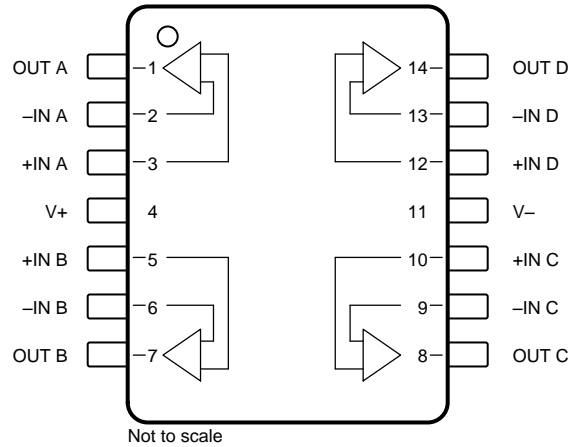
NAME	PIN			I/O	DESCRIPTION
	SC70 (DCK)	SOT-23 (DBV)	SOIC (D)		
-IN	3	4	2	I	Negative (inverting) input
+IN	1	3	3	I	Positive (noninverting) input
NC	—	—	1, 5, 8	—	No internal connection (can be left floating)
OUT	4	1	6	O	Output
V-	2	2	4	—	Negative (lowest) power supply
V+	5	5	7	—	Positive (highest) power supply

**TLV2172: D and DGK Packages  
8-Pin SOIC and VSSOP  
Top View**



**Pin Functions: TLV2172**

NAME	PIN		I/O	DESCRIPTION
	SOIC (D)	VSSOP (DGK)		
-IN A	2	2	I	Inverting input, channel A
-IN B	6	6	I	Inverting input, channel B
+IN A	3	3	I	Noninverting input, channel A
+IN B	5	5	I	Noninverting input, channel B
OUT A	1	1	O	Output, channel A
OUT B	7	7	O	Output, channel B
V-	4	4	—	Negative (lowest) power supply
V+	8	8	—	Positive (highest) power supply

**TLV4172: D and PW Packages  
14-Pin SOIC and TSSOP  
Top View**

**Pin Functions: TLV4172**

NAME	PIN		I/O	DESCRIPTION
	SOIC (D)	TSSOP (PW)		
-IN A	2	2	I	Inverting input, channel A
-IN B	6	6	I	Inverting input, channel B
-IN C	9	9	I	Inverting input, channel C
-IN D	13	13	I	Inverting input, channel D
+IN A	3	3	I	Noninverting input, channel A
+IN B	5	5	I	Noninverting input, channel B
+IN C	10	10	I	Noninverting input, channel C
+IN D	12	12	I	Noninverting input, channel D
OUT A	1	1	O	Output, channel A
OUT B	7	7	O	Output, channel B
OUT C	8	8	O	Output, channel C
OUT D	14	14	O	Output, channel D
V-	11	11	—	Negative (lowest) power supply
V+	4	4	—	Positive (highest) power supply

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT	
Voltage	Supply voltage, V+ to V-	-20	20	V	
	Single-supply voltage	40			
	Signal input pin <sup>(2)</sup>	Common-mode	(V-) - 0.5		(V+) + 0.5
		Differential <sup>(3)</sup>	-0.5		0.5
Current	Signal input pin	-10	10	mA	
	Output short-circuit <sup>(4)</sup>	Continuous			
Temperature	Operating, T <sub>A</sub>	-55	150	°C	
	Junction, T <sub>J</sub>	150			
	Storage, T <sub>stg</sub>	-65	150		

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Transient conditions that exceed these voltage ratings must be current limited to 10 mA or less.

(3) See the *Electrical Overstress* section for more information.

(4) Short-circuit to ground, one amplifier per package.

### 7.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltage, (V+) - (V-)	Single-supply	4.5		36	V
	Dual-supply	±2.25		±18	
Specified temperature		-40		125	°C

## 7.4 Thermal Information: TLV172

THERMAL METRIC <sup>(1)</sup>		TLV172			UNIT
		D (SOIC)	DBV (SOT-23)	DCK (SC70)	
		8 PINS	5 PINS	5 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	126.5	227.9	285.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	80.6	115.7	60.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	67.1	65.9	78.9	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	31.0	10.7	0.8	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	65.6	65.3	77.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	—	—	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 7.5 Thermal Information: TLV2172

THERMAL METRIC <sup>(1)</sup>		TLV2172		UNIT
		D (SOIC)	DGK (VSSOP)	
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	116.1	158	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	69.8	48.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	56.6	78.7	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	22.5	3.9	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	56.1	77.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	—	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 7.6 Thermal Information: TLV4172

THERMAL METRIC <sup>(1)</sup>		TLV4172		UNIT
		D (SOIC)	PW (TSSOP)	
		14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	82.7	111.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	42.3	40.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	37.3	54.1	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	8.9	3.8	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	37	53.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	—	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.



## 7.7 Electrical Characteristics

at  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 2.25\text{ V}$  to  $\pm 18\text{ V}$ ,  $V_{CM} = V_{OUT} = V_S / 2$ , and  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFFSET VOLTAGE</b>						
$V_{OS}$	Input offset voltage	$T_A = 25^\circ\text{C}$		0.5	1.7	mV
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			2	
$dV_{OS}/dT$	Input offset voltage drift	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		1		$\mu\text{V}/^\circ\text{C}$
PSRR	Power-supply rejection ratio	$V_S = 4\text{ V}$ to $36\text{ V}$ , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	100	120		dB
	Channel separation, dc			5		$\mu\text{V}/\text{V}$
<b>INPUT BIAS CURRENT</b>						
$I_B$	Input bias current	$T_A = 25^\circ\text{C}$		$\pm 10$		pA
$I_{OS}$	Input offset current	$T_A = 25^\circ\text{C}$		$\pm 2$		pA
<b>NOISE</b>						
	Input voltage noise	$f = 0.1\text{ Hz}$ to $10\text{ Hz}$		2.5		$\mu\text{V}_{PP}$
$e_n$	Input voltage noise density	$f = 100\text{ Hz}$		14		$\text{nV}/\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$		9		$\text{nV}/\sqrt{\text{Hz}}$
$i_n$	Input current noise density	$f = 1\text{ kHz}$		1.6		$\text{fA}/\sqrt{\text{Hz}}$
<b>INPUT VOLTAGE</b>						
$V_{CM}$	Common-mode voltage range <sup>(1)</sup>		$(V_-) - 0.1$		$(V_+) - 2$	V
CMRR	Common-mode rejection ratio	$V_S = \pm 18\text{ V}$ , $(V_-) - 0.1\text{ V} < V_{CM} < (V_+) - 2\text{ V}$ , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	94	116		dB
<b>INPUT IMPEDANCE</b>						
	Differential			$100 \parallel 4$		$\text{M}\Omega \parallel \text{pF}$
	Common-mode			$6 \parallel 4$		$10^{13}\ \Omega \parallel \text{pF}$
<b>OPEN-LOOP GAIN</b>						
$A_{OL}$	Open-loop voltage gain	$(V_-) + 0.35\text{ V} < V_O < (V_+) - 0.35\text{ V}$ , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	97	115		dB
		$(V_-) + 0.5\text{ V} < V_O < (V_+) - 0.5\text{ V}$ , $R_L = 2\text{ k}\Omega$ , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		107		
<b>FREQUENCY RESPONSE</b>						
GBP	Gain bandwidth product			10		MHz
SR	Slew rate	$G = +1$		10		$\text{V}/\mu\text{s}$
$t_s$	Settling time	To 0.1%, $V_S = \pm 18\text{ V}$ , $G = +1$ , 10-V step		2		$\mu\text{s}$
		To 0.01% (12-bit), $V_S = \pm 18\text{ V}$ , $G = +1$ , 10-V step			3.2	
	Overload recovery time	$V_{IN} \times \text{gain} > V_S$		200		ns
THD+N	Total harmonic distortion + noise	$V_S = 36\text{ V}$ , $G = +1$ , $f = 1\text{ kHz}$ , $V_O = 3.5\text{ V}_{RMS}$		0.0002%		
<b>OUTPUT</b>						
$V_O$	Voltage output swing from rail	$V_S = \pm 18\text{ V}$ , $R_L = 10\text{ k}\Omega$	$T_A = 25^\circ\text{C}$	70		mV
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	95		
		$V_S = \pm 18\text{ V}$ , $R_L = 2\text{ k}\Omega$	$T_A = 25^\circ\text{C}$	330	400	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	470	530	
$I_{SC}$	Short-circuit current			$\pm 75$		mA
$C_{LOAD}$	Capacitive load drive			See <a href="#">Typical Characteristics</a>		pF
$R_O$	Open-loop output resistance	$f = 1\text{ MHz}$ , $I_O = 0\text{ A}$		60		$\Omega$
<b>POWER SUPPLY</b>						
$V_S$	Specified voltage range		4.5		36	V
$I_Q$	Quiescent current per amplifier	$I_O = 0\text{ A}$ , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		1.6	2.3	mA

(1) The input range can be extended beyond  $(V_+) - 2\text{ V}$  up to  $V_+$ . See the [Typical Characteristics](#) and [Application and Implementation](#) sections for additional information.

## 7.8 Typical Characteristics

at  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_{LOAD} = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$  (unless otherwise noted)

**Table 1. Characteristic Performance Measurements**

DESCRIPTION	FIGURE
Offset Voltage Production Distribution	<a href="#">Figure 1</a>
Offset Voltage vs Common-Mode Voltage	<a href="#">Figure 2</a>
Offset Voltage vs Common-Mode Voltage (Upper Stage)	<a href="#">Figure 3</a>
Input Bias Current vs Temperature	<a href="#">Figure 4</a>
Output Voltage Swing vs Output Current (Maximum Supply)	<a href="#">Figure 5</a>
CMRR and PSRR vs Frequency (Referred-to-Input)	<a href="#">Figure 6</a>
0.1-Hz to 10-Hz Noise	<a href="#">Figure 7</a>
Input Voltage Noise Spectral Density vs Frequency	<a href="#">Figure 8</a>
Quiescent Current vs Supply Voltage	<a href="#">Figure 9</a>
Open-Loop Gain and Phase vs Frequency	<a href="#">Figure 10</a>
Closed-Loop Gain vs Frequency	<a href="#">Figure 11</a>
Open-Loop Output Impedance vs Frequency	<a href="#">Figure 12</a>
Small-Signal Overshoot vs Capacitive Load	<a href="#">Figure 13</a> , <a href="#">Figure 14</a>
No Phase Reversal	<a href="#">Figure 15</a>
Small-Signal Step Response (10 mV)	<a href="#">Figure 16</a> , <a href="#">Figure 17</a>
Large-Signal Step Response	<a href="#">Figure 18</a> , <a href="#">Figure 19</a>
Large-Signal Settling Time	<a href="#">Figure 20</a> , <a href="#">Figure 21</a>
Short-Circuit Current vs Temperature	<a href="#">Figure 22</a>
Maximum Output Voltage vs Frequency	<a href="#">Figure 23</a>
EMIRR IN+ vs Frequency	<a href="#">Figure 24</a>

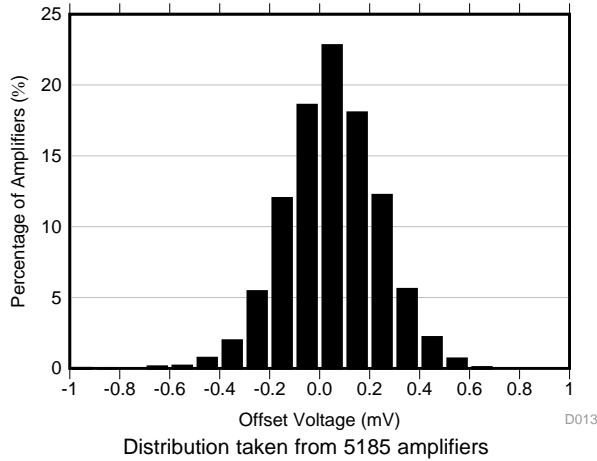


Figure 1. Offset Voltage Production Distribution Histogram

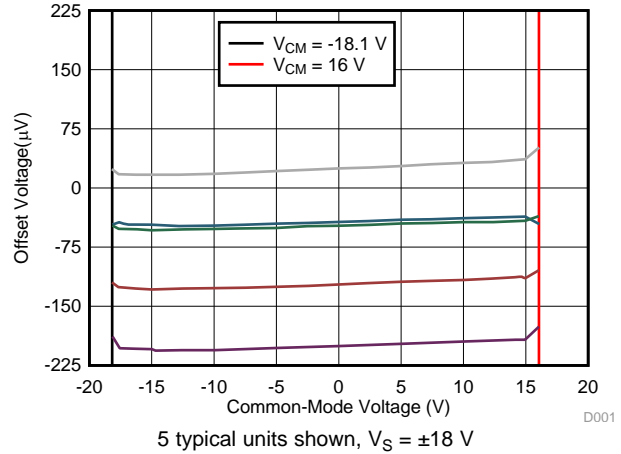


Figure 2. Offset Voltage vs Common-Mode Voltage

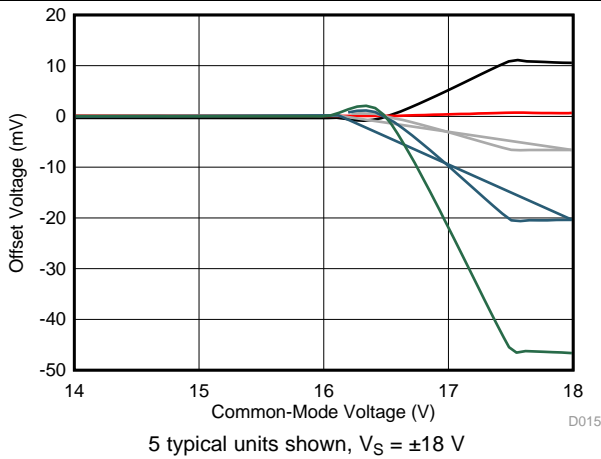


Figure 3. Offset Voltage vs Common-Mode Voltage (Upper Stage)

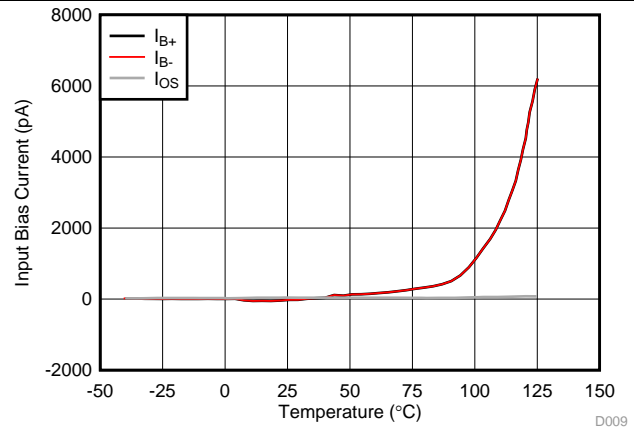


Figure 4. Input Bias Current vs Temperature

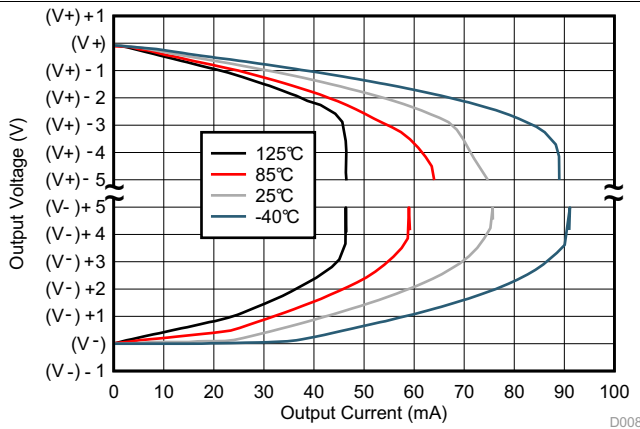


Figure 5. Output Voltage Swing vs Output Current (Maximum Supply)

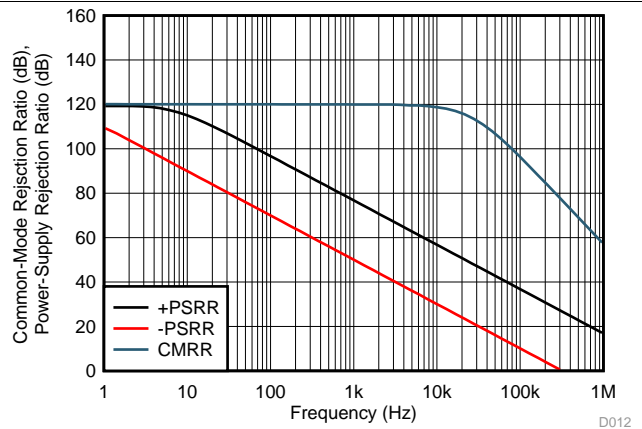


Figure 6. CMRR and PSRR vs Frequency (Referred-to-Input)

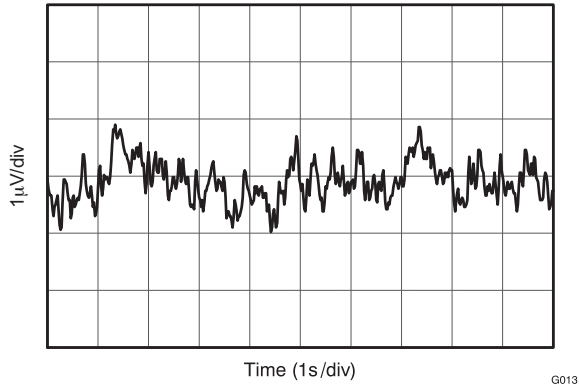


Figure 7. 0.1-Hz to 10-Hz Noise

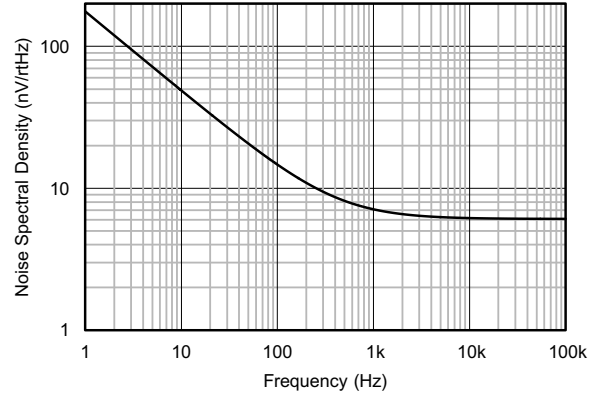


Figure 8. Input Voltage Noise Spectral Density vs Frequency

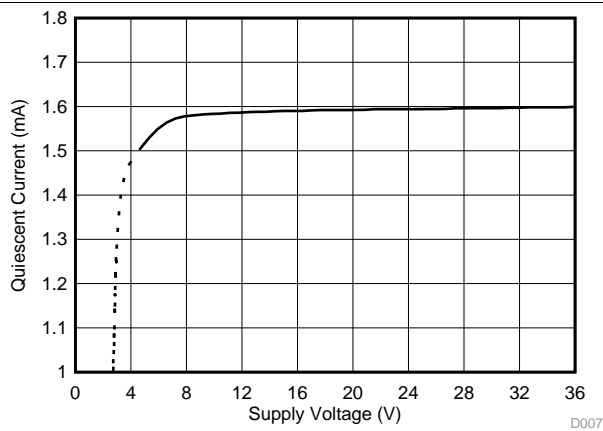


Figure 9. Quiescent Current vs Supply Voltage

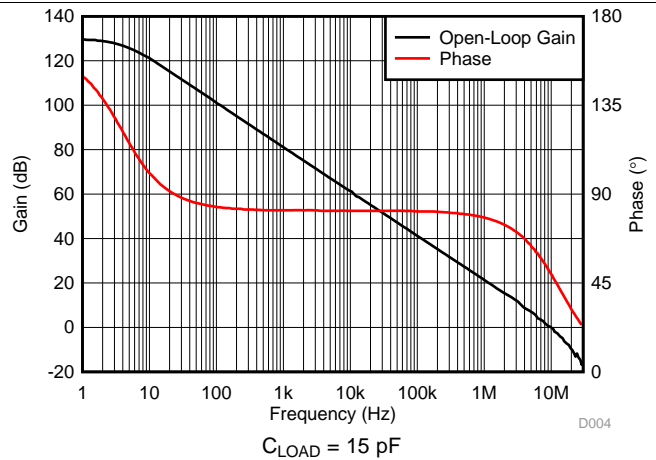


Figure 10. Open-Loop Gain and Phase vs Frequency

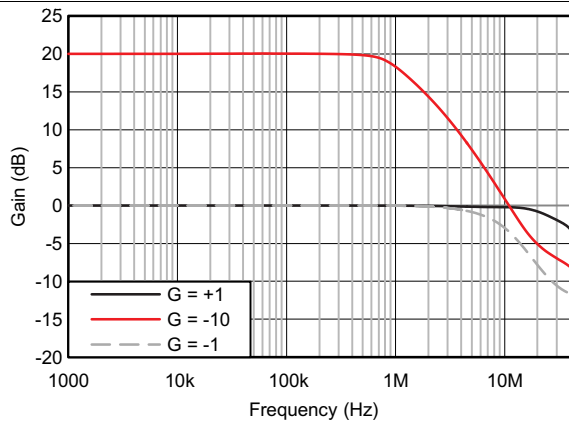


Figure 11. Closed-Loop Gain vs Frequency

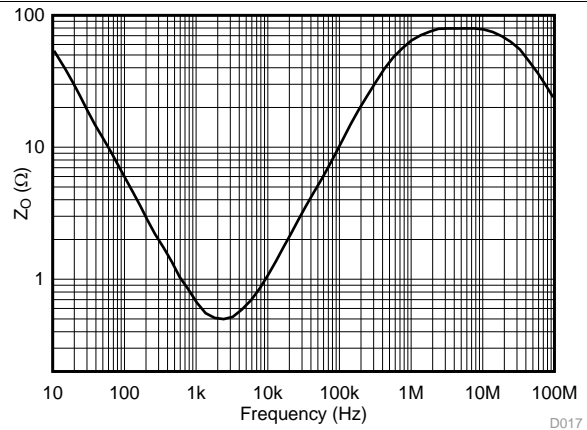


Figure 12. Open-Loop Output Impedance vs Frequency

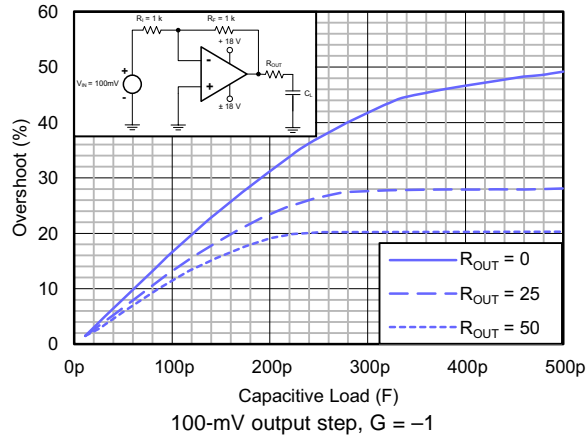


Figure 13. Small-Signal Overshoot vs Capacitive Load

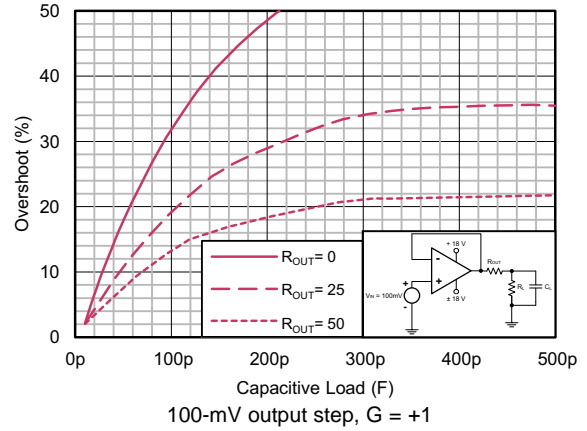


Figure 14. Small-Signal Overshoot vs Capacitive Load

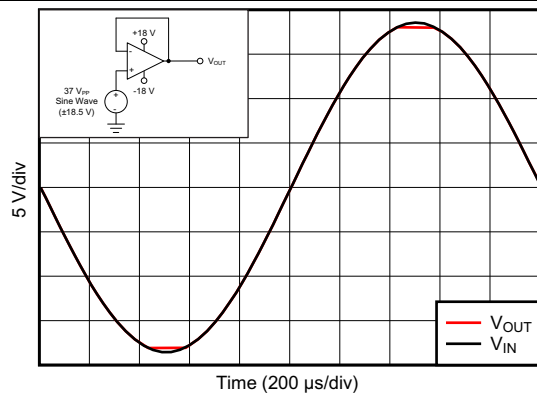
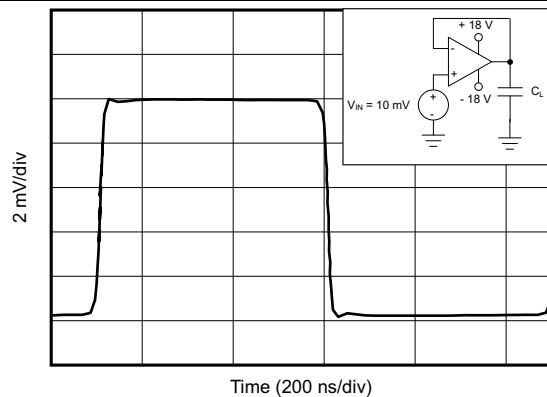
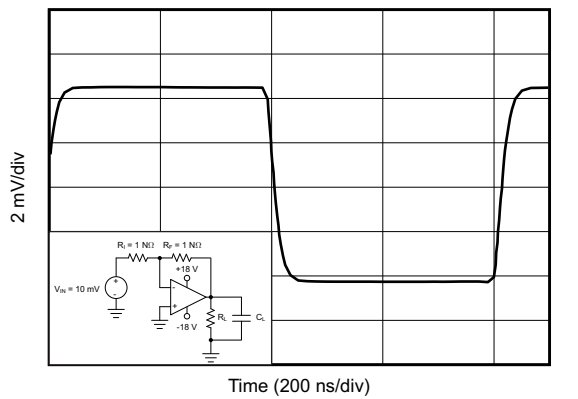


Figure 15. No Phase Reversal



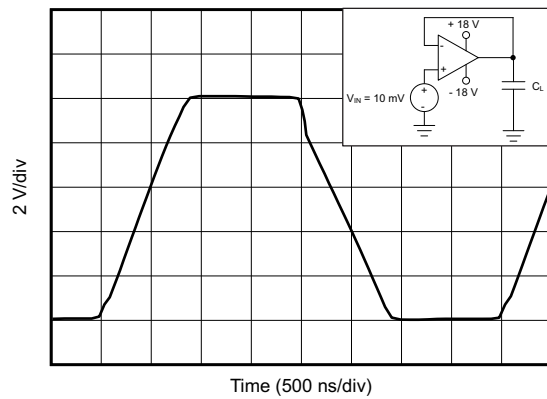
$C_L = 10 \text{ pF}$

Figure 16. Small-Signal Step Response (10 mV)



$R_L = 1 \text{ k}\Omega, C_L = 10 \text{ pF}$

Figure 17. Small-Signal Step Response (10 mV)



$C_L = 10 \text{ pF}$

Figure 18. Large-Signal Step Response

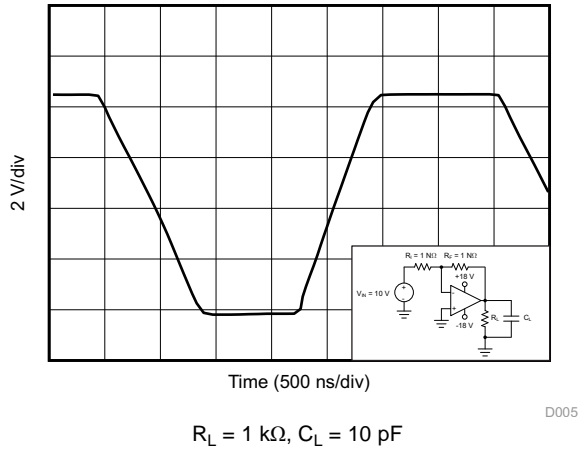


Figure 19. Large-Signal Step Response

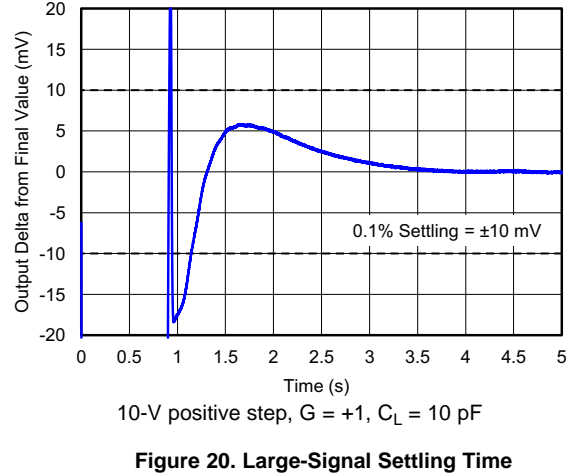


Figure 20. Large-Signal Settling Time

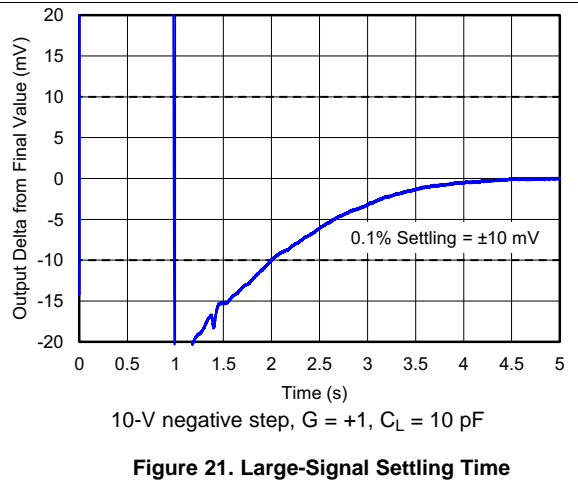


Figure 21. Large-Signal Settling Time

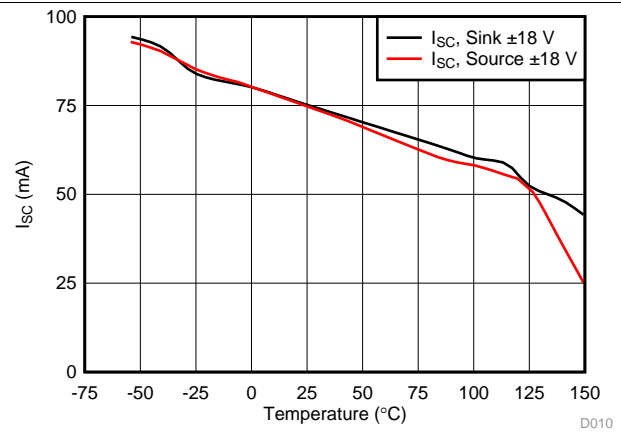


Figure 22. Short-Circuit Current vs Temperature

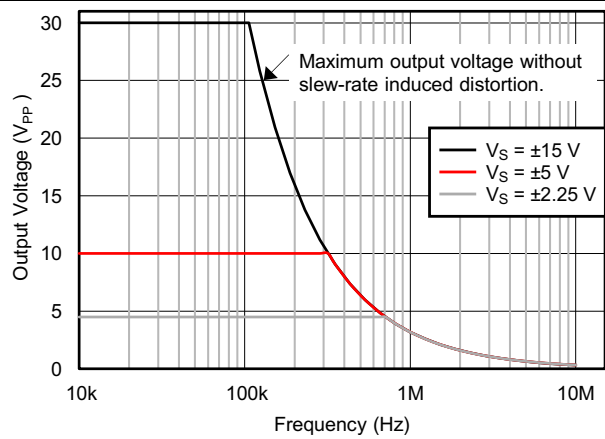


Figure 23. Maximum Output Voltage vs Frequency

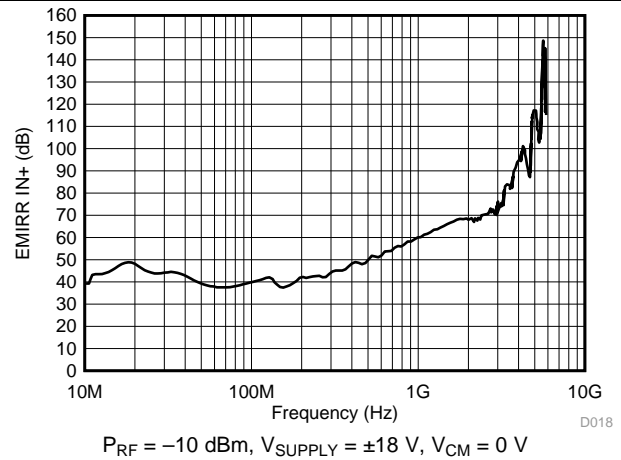


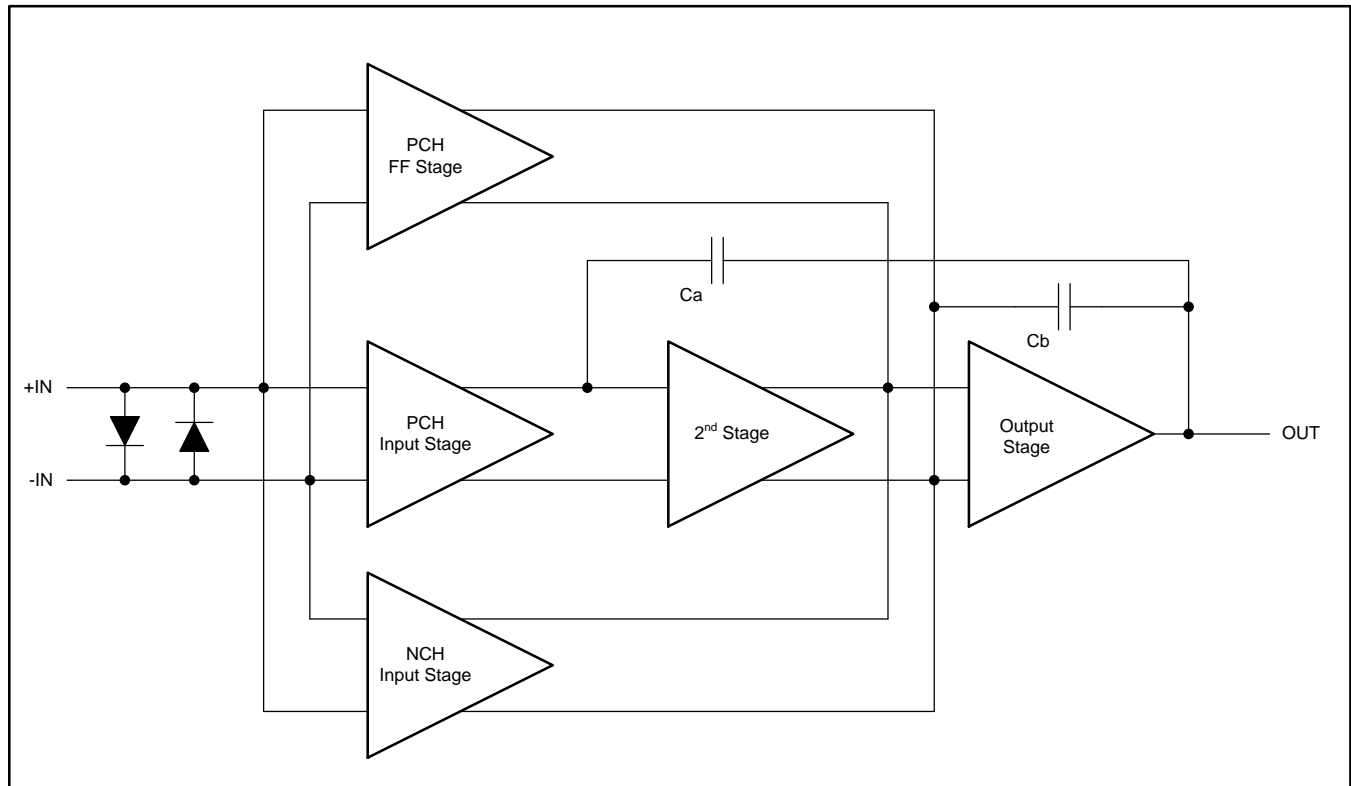
Figure 24. EMIRR IN+ vs Frequency

## 8 Detailed Description

### 8.1 Overview

The TLVx172 family of operational amplifiers provides high overall performance, making these devices ideal for many general-purpose applications. The excellent offset drift of only  $2 \mu\text{V}/^\circ\text{C}$  provides excellent stability over the entire temperature range. In addition, the family offers very good overall performance with high CMRR, PSRR, and  $A_{OL}$ .

### 8.2 Functional Block Diagram



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### 8.3 Feature Description

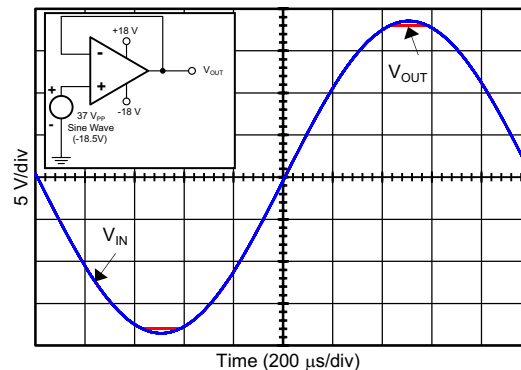
#### 8.3.1 Operating Characteristics

The TLVx172 family of amplifiers is specified for operation from 4.5 V to 36 V ( $\pm 2.25 \text{ V}$  to  $\pm 18 \text{ V}$ ). Many of the specifications apply from  $-40^\circ\text{C}$  to  $+125^\circ\text{C}$ . Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#) section.

## Feature Description (continued)

### 8.3.2 Phase-Reversal Protection

The TLVx172 family has an internal phase-reversal protection. Many operational amplifiers exhibit a phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The input of the TLVx172 prevents phase reversal with excessive common-mode voltage. Instead, the output limits into the appropriate rail. This performance is shown in [Figure 25](#).



**Figure 25. No Phase Reversal**

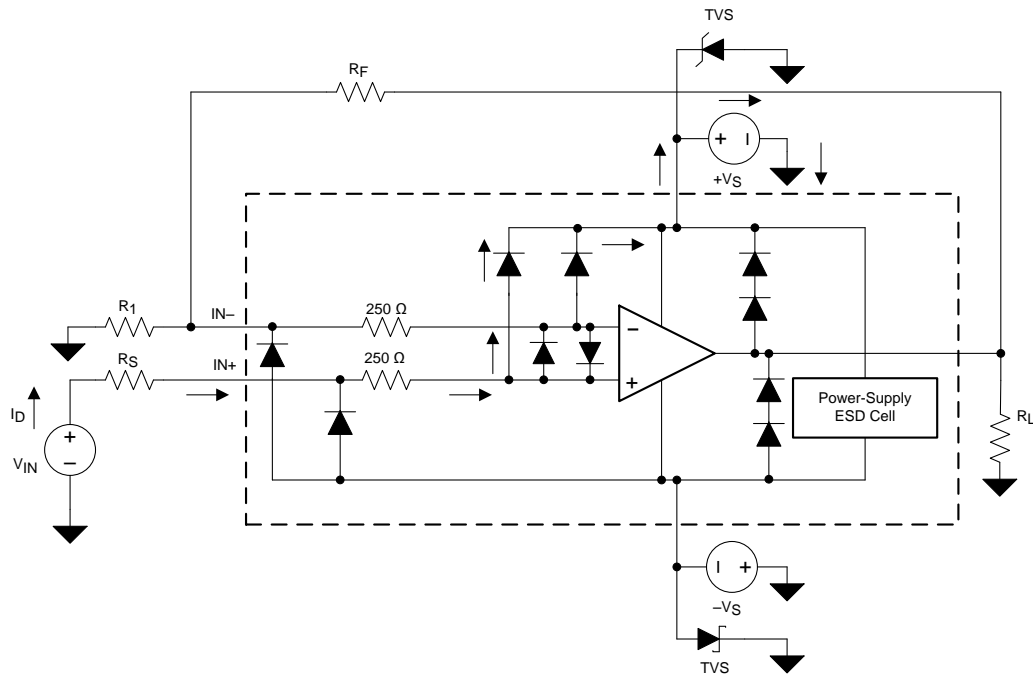
### 8.3.3 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits for protection from accidental ESD events both before and during product assembly.

A good understanding of this basic ESD circuitry and the relevance to an electrical overstress event is helpful. [Figure 26](#) illustrates the ESD circuits contained in the TLVx172 (indicated by the dashed box). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.



## Feature Description (continued)



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**Figure 26. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application**

An ESD event produces a short-duration, high-voltage pulse that is transformed into a short-duration, high-current pulse when discharging through a semiconductor device. The ESD protection circuits are designed to provide a current path around the operational amplifier core to prevent damage. The energy absorbed by the protection circuitry is then dissipated as heat.

When an ESD voltage develops across two or more amplifier device pins, current flows through one or more steering diodes. Depending on the path that the current takes, the absorption device can activate. The absorption device has a trigger, or threshold voltage, that is above the normal operating voltage of the TLVx172 but below the device breakdown voltage level. When this threshold is exceeded, the absorption device quickly activates and clamps the voltage across the supply rails to a safe level.

When the operational amplifier connects into a circuit, as shown in [Figure 26](#), the ESD protection components are intended to remain inactive and do not become involved in the application circuit operation. However, circumstances can arise where an applied voltage exceeds the operating voltage range of a given pin. If this condition occurs, there is a risk that some internal ESD protection circuits can turn on and conduct current. Any such current flow occurs through steering-diode paths and rarely involves the absorption device.

[Figure 26](#) shows a specific example where the input voltage ( $V_{IN}$ ) exceeds the positive supply voltage ( $V+$ ) by 500 mV or more. Much of what happens in the circuit depends on the supply characteristics. If  $V+$  can sink the current, then one of the upper input steering diodes conducts and directs current to  $V+$ . Excessively high current levels can flow with increasingly higher  $V_{IN}$ . As a result, the data sheet specifications recommend that applications limit the input current to 10 mA.

If the supply is not capable of sinking the current,  $V_{IN}$  can begin sourcing current to the operational amplifier and then take over as the source of positive supply voltage. The danger in this case is that the voltage can rise to levels that exceed the operational amplifier absolute maximum ratings.

### Feature Description (continued)

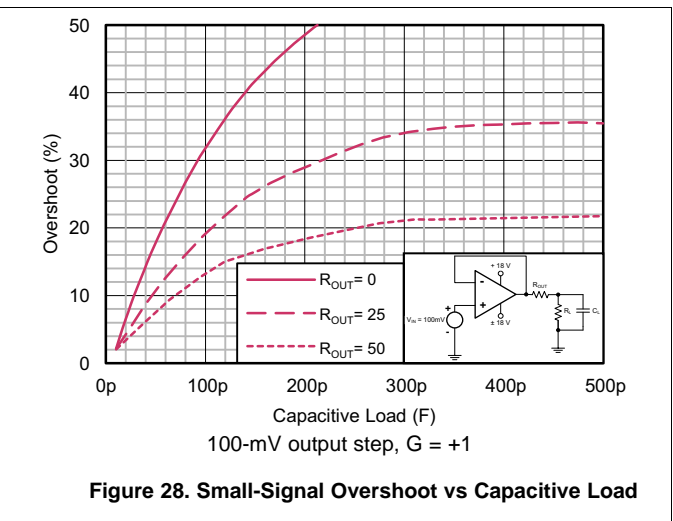
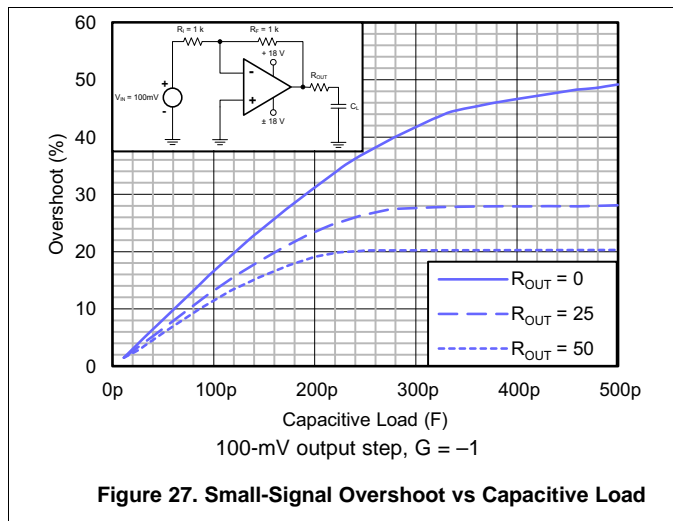
Another common question involves what happens to the amplifier if an input signal is applied to the input when the power supplies ( $V+$  or  $V-$ ) are at 0 V. Again, this question depends on the supply characteristic when at 0 V, or at a level below the input signal amplitude. If the supplies appear as high impedance, then the input source supplies the operational amplifier current through the current-steering diodes. This state is not a normal bias condition; most likely, the amplifier does not operate normally. If the supplies are low impedance, then the current through the steering diodes can become quite high. The current level depends on the ability of the input source to deliver current, and any resistance in the input path.

If there is any uncertainty about the ability of the supply to absorb this current, add external Zener diodes to the supply pins; see [Figure 26](#). Select the Zener voltage so that the diode does not turn on during normal operation. However, the Zener voltage must be low enough so that the Zener diode conducts if the supply pin begins to rise above the safe-operating, supply-voltage level.

The TLVx172 input pins are protected from excessive differential voltage with back-to-back diodes; see [Figure 26](#). In most circuit applications, the input protection circuitry has no effect. However, in low-gain or  $G = 1$  circuits, fast-ramping input signals can forward-bias these diodes because the output of the amplifier cannot respond rapidly enough to the input ramp. If the input signal is fast enough to create this forward-bias condition, then limit the input signal current to 10 mA or less. If the input signal current is not inherently limited, an input series resistor can be used to limit the input signal current. This input series resistor degrades the low-noise performance of the TLVx172. [Figure 26](#) illustrates an example configuration that implements a current-limiting feedback resistor.

#### 8.3.4 Capacitive Load and Stability

The dynamic characteristics of the TLVx172 are optimized for common operating conditions. The combination of low closed-loop gain and high capacitive loads decreases the phase margin of the amplifier and can lead to gain peaking or oscillations. As a result, heavier capacitive loads must be isolated from the output. The simplest way to achieve this isolation is to add a small resistor (for example,  $R_{OUT}$  equal to 50  $\Omega$ ) in series with the output. [Figure 27](#) and [Figure 28](#) show graphs of small-signal overshoot versus capacitive load for several values of  $R_{OUT}$ . Also, see the [Feedback Plots Define Op Amp AC Performance](#) application note for details of analysis techniques and application circuits.



## 8.4 Device Functional Modes

### 8.4.1 Common-Mode Voltage Range

The input common-mode voltage range of the TLVx172 family extends 100 mV below the negative rail and within 2 V of the top rail for normal operation.

This device can operate with full rail-to-rail input 100 mV beyond the top rail, but with reduced performance within 2 V of the top rail. The typical performance in this range is summarized in [Table 2](#).

**Table 2. Typical Performance for Common-Mode Voltages Within 2 V of the Positive Supply**

PARAMETER	MIN	TYP	MAX	UNIT
Input common-mode voltage	(V+) – 2		(V+) + 0.1	V
Offset voltage		7		mV
Offset voltage vs temperature		12		μV/°C
Common-mode rejection		65		dB
Open-loop gain		60		dB
Gain-bandwidth product		0.3		MHz
Slew rate		0.3		V/μs

### 8.4.2 Overload Recovery

Overload recovery is defined as the time required for the operational amplifier output to recover from the saturated state to the linear state. The output devices of the operational amplifier enter the saturation region when the output voltage exceeds the rated operating voltage, either resulting from the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices need time to return back to the normal state. After the charge carriers return back to the equilibrium state, the device begins to slew at the normal slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time. The overload recovery time for the TLVx172 is approximately 2 μs.

## 9 Application and Implementation

### NOTE

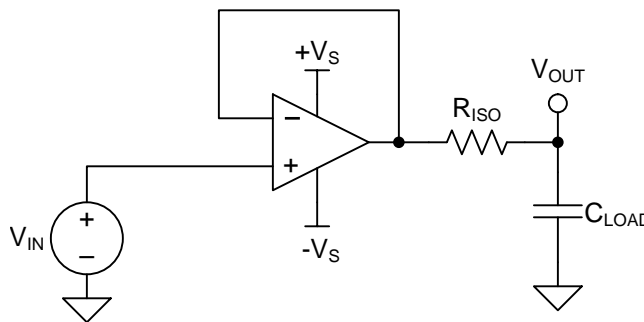
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TLVx172 family of operational amplifiers provides high overall performance in a large number of general-purpose applications. As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors placed close to the device pins. In most cases, 0.1- $\mu$ F capacitors are adequate. Follow the additional recommendations in the [Layout Guidelines](#) section in order to achieve the maximum performance from this device. Many applications can introduce capacitive loading to the output of the amplifier (potentially causing instability). One method of stabilizing the amplifier in such applications is to add an isolation resistor between the amplifier output and the capacitive load. The design process for selecting this resistor is given in the [Typical Application](#) section.

### 9.2 Typical Application

This circuit can be used to drive capacitive loads (such as cable shields, reference buffers, MOSFET gates, and diodes). The circuit uses an isolation resistor ( $R_{ISO}$ ) to stabilize the output of an operational amplifier.  $R_{ISO}$  modifies the open-loop gain of the system to ensure that the circuit has sufficient phase margin.



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**Figure 29. Unity-Gain Buffer With  $R_{ISO}$  Stability Compensation**

#### 9.2.1 Design Requirements

The design requirements are:

- Supply voltage: 30 V ( $\pm 15$  V)
- Capacitive loads: 100 pF, 1000 pF, 0.01  $\mu$ F, 0.1  $\mu$ F, and 1  $\mu$ F
- Phase margin: 45° and 60°

#### 9.2.2 Detailed Design Procedure

Figure 29 shows a unity-gain buffer driving a capacitive load. Equation 1 shows the transfer function for the circuit in Figure 29. Not shown in Figure 29 is the open-loop output resistance of the operational amplifier,  $R_o$ .

$$T(s) = \frac{1 + C_{LOAD} \times R_{ISO} \times s}{1 + (R_o + R_{ISO}) \times C_{LOAD} \times s} \quad (1)$$

The transfer function in Equation 1 has a pole and a zero. The frequency of the pole ( $f_p$ ) is determined by  $(R_o + R_{ISO})$  and  $C_{LOAD}$ . Components  $R_{ISO}$  and  $C_{LOAD}$  determine the frequency of the zero ( $f_z$ ). A stable system is obtained by selecting  $R_{ISO}$  such that the rate of closure (ROC) between the open-loop gain ( $A_{OL}$ ) and  $1/\beta$  is 20 dB per decade. Figure 30 depicts the concept. The  $1/\beta$  curve for a unity-gain buffer is 0 dB.

Typical Application (continued)



Figure 30. Unity-Gain Amplifier With R<sub>ISO</sub> Compensation

ROC stability analysis is typically simulated. The validity of the analysis depends on multiple factors, especially the accurate modeling of R<sub>o</sub>. In addition to simulating the ROC, a robust stability analysis includes a measurement of overshoot percentage and ac gain peaking of the circuit using a function generator, oscilloscope, and gain and phase analyzer. Phase margin is then calculated from these measurements. Table 3 shows the overshoot percentage and ac gain peaking that correspond to phase margins of 45° and 60°. For more details on this design and other alternative devices that can be used in place of the TLV172, see the [Capacitive Load Drive Solution Using an Isolation Resistor](#) precision design.

Table 3. Phase Margin versus Overshoot and AC Gain Peaking

PHASE MARGIN	OVERSHOOT	AC GAIN PEAKING
45°	23.3%	2.35 dB
60°	8.8%	0.28 dB

9.2.3 Application Curve

Using the described methodology, the values of R<sub>ISO</sub> that yield phase margins of 45° and 60° for various capacitive loads were determined. The results are shown in Figure 31.

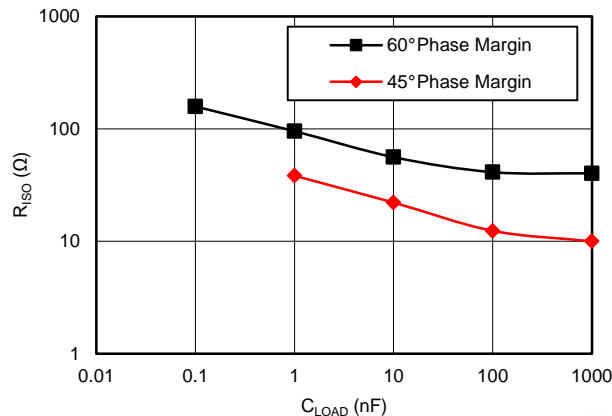


Figure 31. Isolation Resistor Required for Various Capacitive Loads to Achieve a Target Phase Margin

## 10 Power Supply Recommendations

The TLVx172 is specified for operation from 4.5 V to 36 V ( $\pm 2.25$  V to  $\pm 18$  V); many specifications apply from  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ . Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#) section.

### CAUTION

Supply voltages larger than 40 V can permanently damage the device; see the [Absolute Maximum Ratings](#) table.

Place 0.1- $\mu\text{F}$  bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, see the [Layout](#) section.

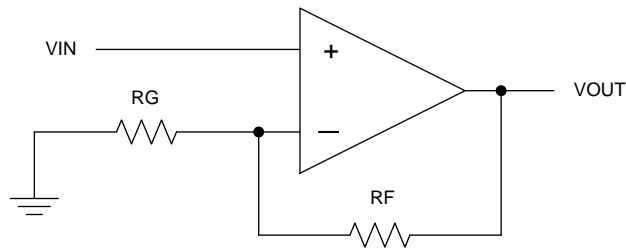
## 11 Layout

### 11.1 Layout Guidelines

For best operational performance of the device, use good printed circuit board (PCB) layout practices, including:

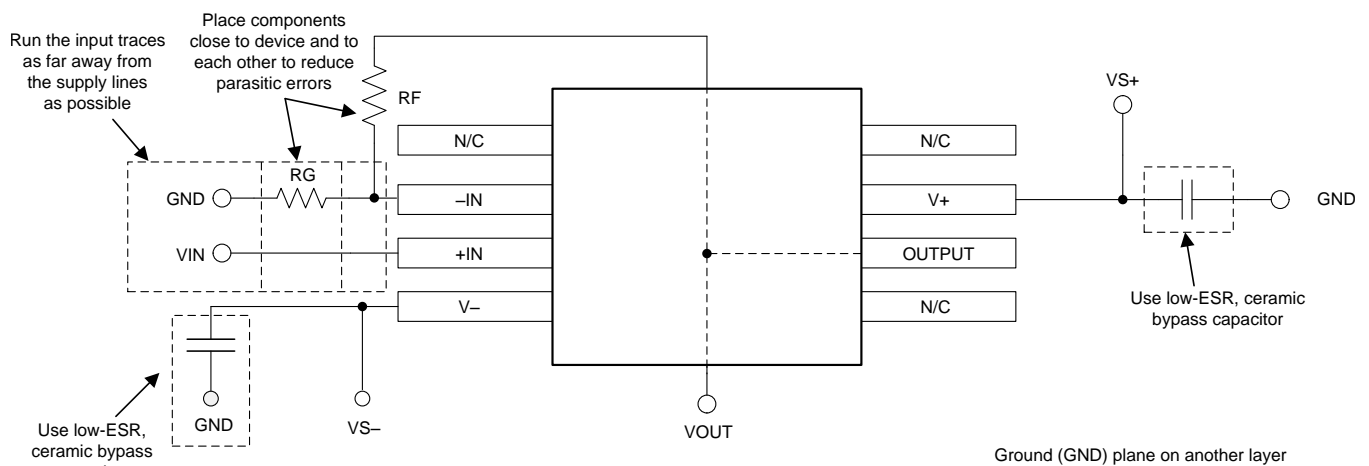
- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and the operational amplifier itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
  - Connect low-ESR, 0.1- $\mu\text{F}$  ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
- Separate grounding for analog and digital portions of the circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces electromagnetic interference (EMI) noise pickup. Make sure to physically separate digital and analog grounds, paying attention to the flow of the ground current.
- In order to reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicularly is much better than in parallel with the noisy trace.
- Place the external components as close to the device as possible. As illustrated in [Figure 33](#), keeping  $R_F$  and  $R_G$  close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

## 11.2 Layout Example



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**Figure 32. Schematic Representation**



**Figure 33. Operational Amplifier Board Layout for a Noninverting Configuration**

## 12 器件和文档支持

### 12.1 器件支持

#### 12.1.1 开发支持

##### 12.1.1.1 TINA-TI™ (免费下载)

TINA-TI™ 是一款基于 SPICE 引擎的电路仿真程序，简单易用并且功能强大。TINA-TI™ 是 TINA 软件的一款免费全功能版本，除了一系列无源和有源模型外，此版本软件还预先载入了一个宏模型库。TINA-TI™ 提供所有传统的 SPICE 直流、瞬态和频域分析，以及其他设计功能。

TINA-TI™ 提供全面的后处理能力，便于用户以多种方式获得结果，用户可从 Analog eLab Design Center（模拟电子实验室设计中心）[免费下载](#)。虚拟仪器提供选择输入波形和探测电路节点、电压以及波形的功能，从而构建一个动态快速入门工具。

#### 注

这些文件需要安装 TINA 软件（由 DesignSoft™ 提供）或者 TINA-TI™ 软件。请下载 [TINA-TI™ 文件夹](#) 中的免费 TINA-TI™ 软件。

##### 12.1.1.2 DIP 适配器 EVM

**DIP 适配器 EVM** 工具为小型表面贴装器件的原型设计提供了一种简易的低成本方法。评估工具使用以下 TI 封装：D 或 U (SOIC-8)、PW (TSSOP-8)、DGK (VSSOP-8)、DBV (SOT23-6、SOT23-5 和 SOT23-3)、DCK (SC70-6 和 SC70-5) 以及 DRL (SOT563-6)。DIP 适配器 EVM 也可搭配引脚排使用，或者直接与现有电路相连。

##### 12.1.1.3 通用运放 EVM

**通用运放 EVM** 是一系列通用空白电路板，可简化采用各种器件封装类型的电路板原型设计。借助评估模块电路板设计，可以轻松快速地构造多种不同电路。共有 5 个模型可供选用，每个模型都对应一种特定封装类型。支持 PDIP、SOIC、VSSOP、TSSOP 和 SOT23 封装。

#### 注

这些电路板均为空白电路板，用户必须自行提供相关器件。TI 建议您在订购通用运放 EVM 时申请几个运放器件样品。

##### 12.1.1.4 TI 高精度设计

TI 高精度设计是由 TI 公司高精度模拟应用专家创建的模拟解决方案，提供了许多实用电路的工作原理、组件选择、仿真、完整印刷电路板 (PCB) 电路原理图和布局布线、物料清单以及性能测量结果。TI 高精度设计可从 [www.ti.com/ww/en/analog/precision-designs/](http://www.ti.com/ww/en/analog/precision-designs/) 在线获取。

##### 12.1.1.5 WEBENCH® 滤波器设计器

**WEBENCH® 滤波器设计器** 是一款简单、功能强大且便于使用的有源滤波器设计程序。此 WEBENCH® Filter Designer 通过选择 TI 运算放大器以及 TI 供应商合作伙伴的无源组件构建优化滤波器设计方案。

WEBENCH® 设计中心以基于网络的工具形式提供 WEBENCH® 滤波器设计器。用户通过该工具可在短时间内完成多级有源滤波器解决方案的设计、优化和仿真。



## 12.2 文档支持

### 12.2.1 相关文档

相关文档如下：

- 《[反馈曲线图定义运算放大器交流性能](#)》（文献编号：SBOA015）
- 《[运算放大器的 EMI 抑制比](#)》应用报告（文献编号：SBOA128）。
- 《[直观补偿互阻抗放大器](#)》应用报告（文献编号：SBOA055）
- 《[高速运算放大器噪声分析](#)》应用报告（文献编号：SBOA066）

### 12.3 相关链接

**表 4** 列出了快速访问链接。范围包括技术文档、支持与社区资源、工具和软件，并且可以快速访问样片或购买链接。

**表 4. 相关链接**

器件	产品文件夹	样片与购买	技术文档	工具与软件	支持与社区
TLV172	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>
TLV2172	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>
TLV4172	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>	<a href="#">请单击此处</a>

### 12.4 接收文档更新通知

如需接收文档更新通知，请访问 [ti.com](http://ti.com) 上的器件产品文件夹。点击右上角的提醒我 (Alert me) 注册后，即可每周定期收到已更改的产品信息。有关更改的详细信息，请查阅已修订文档中包含的修订历史记录。

### 12.5 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 12.6 商标

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### 12.7 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

### 12.8 Glossary

**SLYZ022** — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

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	产品		应用
数字音频	<a href="http://www.ti.com.cn/audio">www.ti.com.cn/audio</a>	通信与电信	<a href="http://www.ti.com.cn/telecom">www.ti.com.cn/telecom</a>
放大器和线性器件	<a href="http://www.ti.com.cn/amplifiers">www.ti.com.cn/amplifiers</a>	计算机及周边	<a href="http://www.ti.com.cn/computer">www.ti.com.cn/computer</a>
数据转换器	<a href="http://www.ti.com.cn/dataconverters">www.ti.com.cn/dataconverters</a>	消费电子	<a href="http://www.ti.com.cn/consumer-apps">www.ti.com.cn/consumer-apps</a>
DLP® 产品	<a href="http://www.dlp.com">www.dlp.com</a>	能源	<a href="http://www.ti.com.cn/energy">www.ti.com.cn/energy</a>
DSP - 数字信号处理器	<a href="http://www.ti.com.cn/dsp">www.ti.com.cn/dsp</a>	工业应用	<a href="http://www.ti.com.cn/industrial">www.ti.com.cn/industrial</a>
时钟和计时器	<a href="http://www.ti.com.cn/clockandtimers">www.ti.com.cn/clockandtimers</a>	医疗电子	<a href="http://www.ti.com.cn/medical">www.ti.com.cn/medical</a>
接口	<a href="http://www.ti.com.cn/interface">www.ti.com.cn/interface</a>	安防应用	<a href="http://www.ti.com.cn/security">www.ti.com.cn/security</a>
逻辑	<a href="http://www.ti.com.cn/logic">www.ti.com.cn/logic</a>	汽车电子	<a href="http://www.ti.com.cn/automotive">www.ti.com.cn/automotive</a>
电源管理	<a href="http://www.ti.com.cn/power">www.ti.com.cn/power</a>	视频和影像	<a href="http://www.ti.com.cn/video">www.ti.com.cn/video</a>
微控制器 (MCU)	<a href="http://www.ti.com.cn/microcontrollers">www.ti.com.cn/microcontrollers</a>		
RFID 系统	<a href="http://www.ti.com.cn/rfidsys">www.ti.com.cn/rfidsys</a>		
OMAP应用处理器	<a href="http://www.ti.com/omap">www.ti.com/omap</a>		
无线连通性	<a href="http://www.ti.com.cn/wirelessconnectivity">www.ti.com.cn/wirelessconnectivity</a>	德州仪器在线技术支持社区	<a href="http://www.deyisupport.com">www.deyisupport.com</a>

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**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLV172IDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	18VV	<a href="#">Samples</a>
TLV172IDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	18VV	<a href="#">Samples</a>
TLV172IDCKR	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	15W	<a href="#">Samples</a>
TLV172IDCKT	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	15W	<a href="#">Samples</a>
TLV172IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV172	<a href="#">Samples</a>
TLV2172IDGKR	ACTIVE	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	14P6	<a href="#">Samples</a>
TLV2172IDGKT	ACTIVE	VSSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	14P6	<a href="#">Samples</a>
TLV2172IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TL2172	<a href="#">Samples</a>
TLV4172IDR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4172	<a href="#">Samples</a>
TLV4172IPWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV4172	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-203 variation AA.

DCK (R-PDSO-G5)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  -  Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  -  Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AB.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# MECHANICAL DATA

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  -  C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  -  D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4211284-2/G 08/15

- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AA.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE

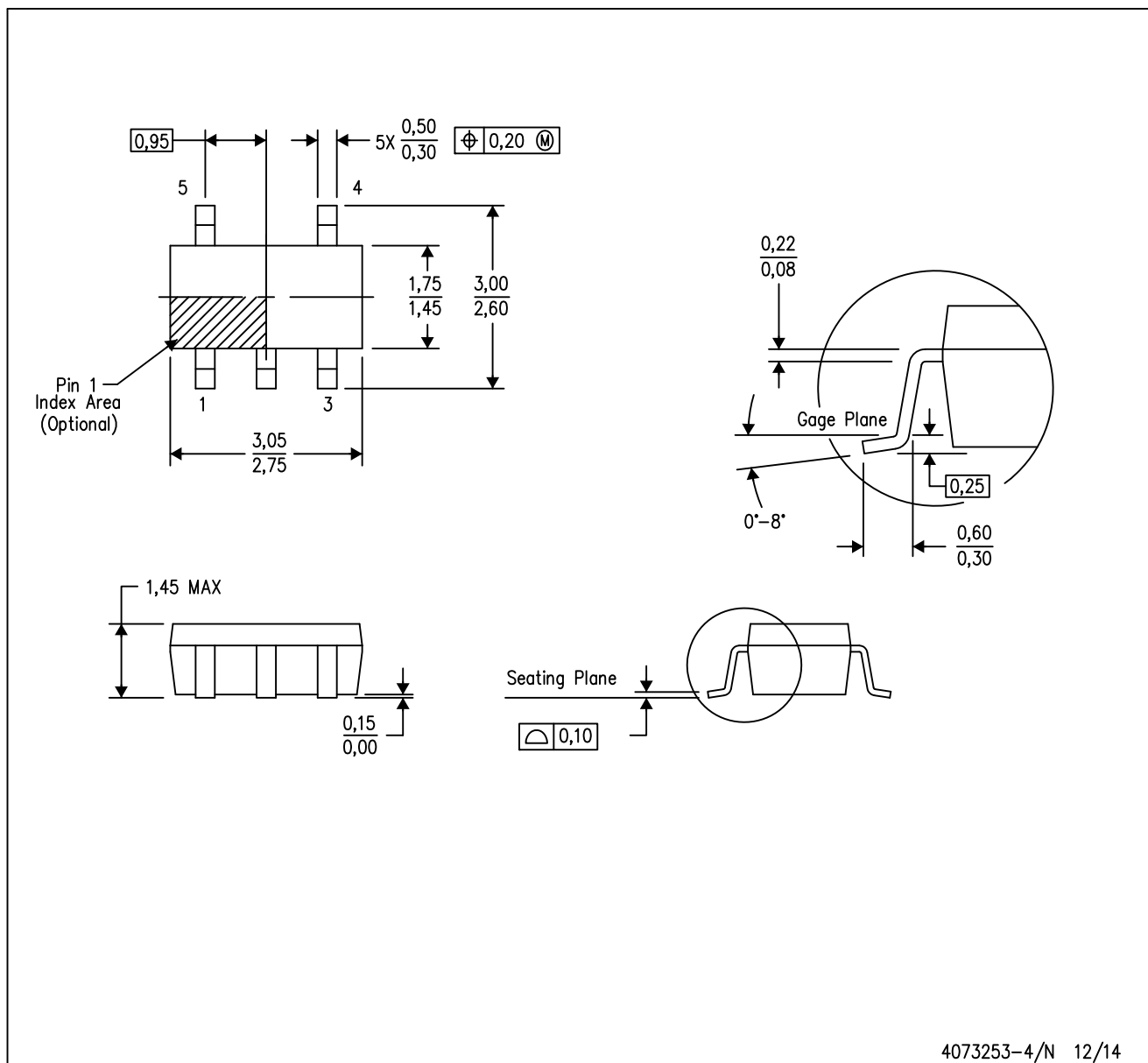


4211283-2/E 08/12

- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-178 Variation AA.

DBV (R-PDSO-G5)

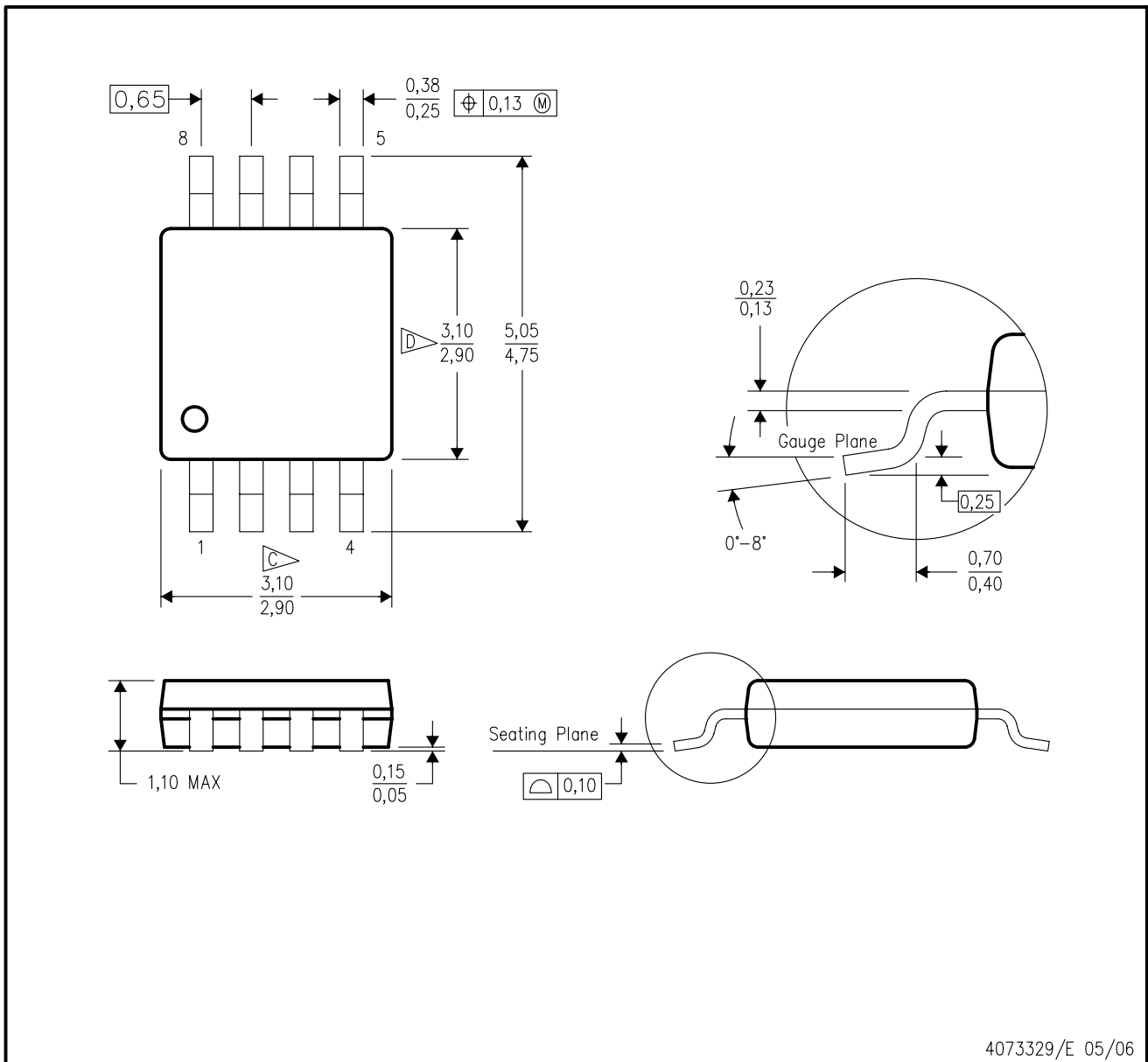
PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
  - D. Publication IPC-7351 is recommended for alternate designs.
  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
  - E. Falls within JEDEC MO-187 variation AA, except interlead flash.



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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只有那些 TI 特别注明属于军用等级或“增强型塑料”的 TI 组件才是设计或专门用于军事/航空应用或环境的。购买者认可并同意, 对并非指定面向军事或航空航天用途的 TI 组件进行军事或航空航天方面的应用, 其风险由客户单独承担, 并且由客户独自负责满足与此类使用相关的所有法律和法规要求。

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	产品		应用
数字音频	<a href="http://www.ti.com.cn/audio">www.ti.com.cn/audio</a>	通信与电信	<a href="http://www.ti.com.cn/telecom">www.ti.com.cn/telecom</a>
放大器和线性器件	<a href="http://www.ti.com.cn/amplifiers">www.ti.com.cn/amplifiers</a>	计算机及周边	<a href="http://www.ti.com.cn/computer">www.ti.com.cn/computer</a>
数据转换器	<a href="http://www.ti.com.cn/dataconverters">www.ti.com.cn/dataconverters</a>	消费电子	<a href="http://www.ti.com.cn/consumer-apps">www.ti.com.cn/consumer-apps</a>
DLP® 产品	<a href="http://www.dlp.com">www.dlp.com</a>	能源	<a href="http://www.ti.com.cn/energy">www.ti.com.cn/energy</a>
DSP - 数字信号处理器	<a href="http://www.ti.com.cn/dsp">www.ti.com.cn/dsp</a>	工业应用	<a href="http://www.ti.com.cn/industrial">www.ti.com.cn/industrial</a>
时钟和计时器	<a href="http://www.ti.com.cn/clockandtimers">www.ti.com.cn/clockandtimers</a>	医疗电子	<a href="http://www.ti.com.cn/medical">www.ti.com.cn/medical</a>
接口	<a href="http://www.ti.com.cn/interface">www.ti.com.cn/interface</a>	安防应用	<a href="http://www.ti.com.cn/security">www.ti.com.cn/security</a>
逻辑	<a href="http://www.ti.com.cn/logic">www.ti.com.cn/logic</a>	汽车电子	<a href="http://www.ti.com.cn/automotive">www.ti.com.cn/automotive</a>
电源管理	<a href="http://www.ti.com.cn/power">www.ti.com.cn/power</a>	视频和影像	<a href="http://www.ti.com.cn/video">www.ti.com.cn/video</a>
微控制器 (MCU)	<a href="http://www.ti.com.cn/microcontrollers">www.ti.com.cn/microcontrollers</a>		
RFID 系统	<a href="http://www.ti.com.cn/rfidsys">www.ti.com.cn/rfidsys</a>		
OMAP应用处理器	<a href="http://www.ti.com.cn/omap">www.ti.com.cn/omap</a>		
无线连通性	<a href="http://www.ti.com.cn/wirelessconnectivity">www.ti.com.cn/wirelessconnectivity</a>	德州仪器在线技术支持社区	<a href="http://www.deyisupport.com">www.deyisupport.com</a>

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